

UF1010-S

Preliminary

Power MOSFET

84A, 60V N-CHANNEL POWER MOSFET

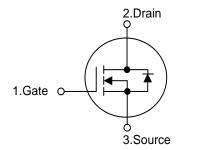
DESCRIPTION

The UTC UF1010-S is a N-channel mode power MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications at power supplies, PWM motor controls, high efficient AC to DC converters and bridge circuits.

FEATURES

- * $R_{DS(ON)} \le 12 \text{ m}\Omega$ @ $V_{GS} = 10V$, $I_D = 50A$
- * Fast Switching Capability
- * Improved dv/dt Capability, High Ruggedness

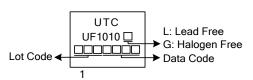
SYMBOL

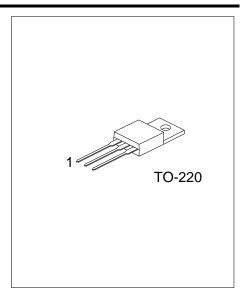


ORDERING INFORMATION

Ordering	Package	Pin Assignment			Decking		
Lead Free	Lead Free Halogen Free		1	2	3	Packing	
UF1010L-TA3-T	UF1010L-TA3-T UF1010G-TA3-T		G	D	S	Tube	
Note: Pin Assignment: G: Gate D: Drain S: Source							
UF1010G- <u>TA3-T</u> (1)Packing Type (2)Package Type (3)Green Package		 (1) T: Tube (2) TA3: TO-220 (3) G: Halogen Free and Lead Free, L: Lead Free 					

MARKING





■ ABSOLUTE MAXIMUM RATINGS (T_c = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V _{DSS}	60	V
Gate-Source Voltage		V _{GSS}	±20	V
Drain Current	Continuous	I _D	84	А
	Pulsed (Note 2)	I _{DM}	330	А
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	490	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	11	V/ns
Power Dissipation		P _D	200	W
Junction Temperature		TJ	+150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating : Pulse width limited by maximum junction temperature.

3. L = 0.1 mH, I_{AS} = 99 A, V_{DD} = 50V, R_G = 25 Ω, Starting T_J = 25°C

4. $I_{SD} \le 30A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ _{JA}	62	°C/W	
Junction to Case	θ _{JC}	0.75	°C/W	

■ ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

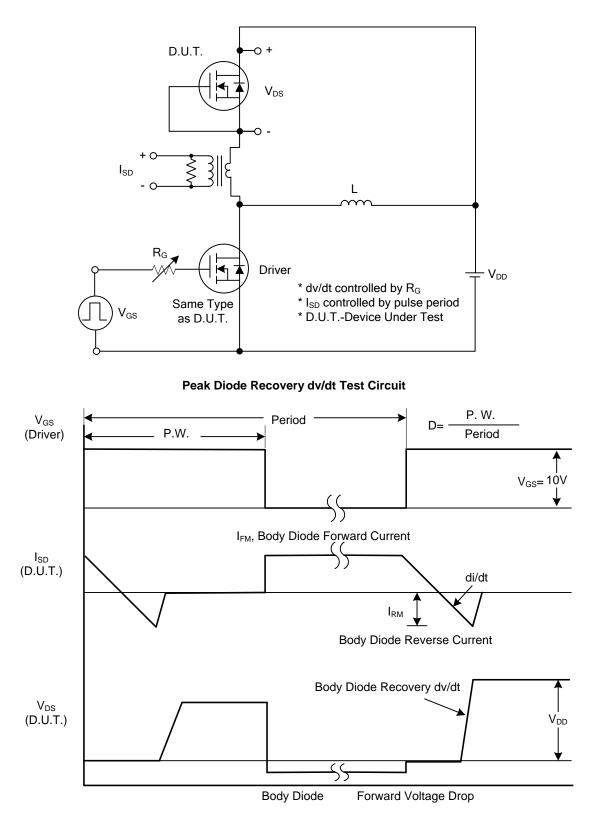
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	V _{GS} =0V, Ι _D =250μΑ	60			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} =60V, V _{GS} =0V			1	μA
Gate-Source Leakage Current	Forward		V _{GS} =20V, V _{DS} =0V			100	nA
	Reverse	I _{GSS}	V _{GS} =-20V, V _{DS} =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		V _{GS(TH)}	V _{DS} =V _{GS} , I _D =250µA			3.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =50A			12	mΩ
DYNAMIC CHARACTERISTICS							
Input Capacitance		CISS			3385		рF
Output Capacitance		Coss	V _{GS} =0V, V _{DS} =25V, f=1.0MHz		580		рF
Reverse Transfer Capacitance		C _{RSS}			80		рF
SWITCHING CHARACTERISTICS							
Total Gate Charge (Note 1)		Q_{G}			224		nC
Gate to Source Charge		Q _{GS}	V _{DS} =50V, V _{GS} =10V, I _D =1.3A , I _G =100µA (Note 1, 2)		14.7		nC
Gate to Drain Charge		Q _{GD}			21.6		nC
Turn-ON Delay Time (Note 1)		t _{D(ON)}			60		ns
Rise Time		t _R	V_{DD} =30V, V_{GS} =10V, I_{D} =0.5A,		105		ns
Turn-OFF Delay Time		t _{D(OFF)}	R _G =25Ω (Note 1, 2)		1180		ns
Fall-Time		t _F			345		ns
SOURCE- DRAIN DIODE RATING	S AND CHA	RACTERISTI	CS				
Maximum Body-Diode Continuous Current		Is				84	Α
Maximum Body-Diode Pulsed Current		I _{SM}				330	Α
Drain-Source Diode Forward Voltage (Note 1)		V _{SD}	I _S =30A, V _{GS} =0V			1.3	V
Body Diode Reverse Recovery Time (Note 1)		t _{rr}	I _S =30A, V _{GS} =0V,		55		ns
Body Diode Reverse Recovery Cha	Q _{rr}	dI _F /dt=100A/µs		102		μC	
Notos: 1 Pulso Tost: Pulso width <	200us Duty	$a_{10} < 20/$					

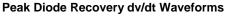
Notes: 1. Pulse Test: Pulse width \leq 300µs, Duty cycle \leq 2%.

2. Essentially independent of operating temperature.



TEST CIRCUITS AND WAVEFORMS

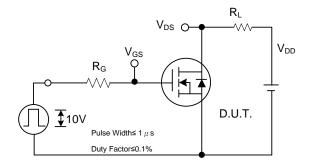


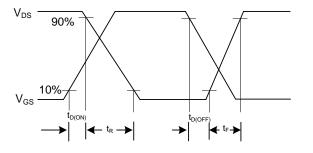




UF1010-S

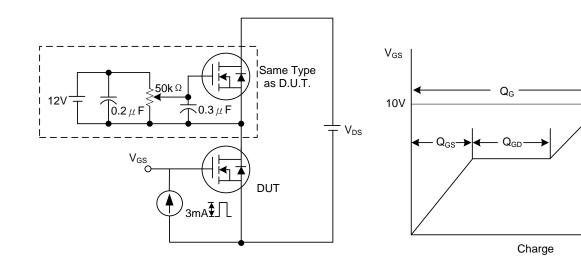
■ TEST CIRCUITS AND WAVEFORMS (Cont.)





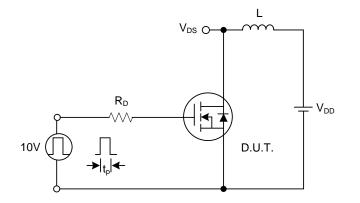
Switching Test Circuit



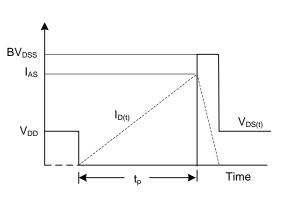


Gate Charge Test Circuit

Gate Charge Waveform



Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms



UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. The information presented in this document does not form part of any quotation or contract, is believed to be accurate and reliable and may be changed without notice.

